

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10584307	TANAKA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Arnberg, Megan	1796

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
428	413	Jan. 25, 2008	MCA
428	413	Sept. 9, 2008	MCM

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor name search -see printout	Jan. 25, 2008	MCA
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT) - see printout	Jan. 25, 2008	MCA
STN structure search -see printout	Jan. 25, 2008	MCA
Updated Inventor name search -see printout	Sept. 9, 2008	MCM
Updated EAST search -see printout	Sept. 9, 2008	MCM
Updated STN structure search -see printout	Sept. 9, 2008	MCM

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/M. M./  
Examiner.Art Unit 1796